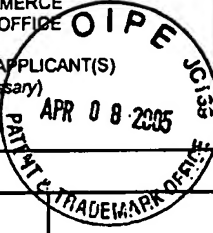
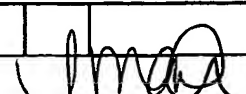


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				APPLICANT NOBUYUKI HATASA, et al.			
				FILING DATE November 24, 2003		GROUP 2861	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
LEM		6,270,206	8/01	Shimizu, et al.	347	86	
LEM		6,382,783	5/02	Hayashi, et al.	347	85	
LEM		6,402,308	6/02	Hattori, et al.	347	86	
LEM		6,422,674	7/02	Hinami, et al.	347	7	
LEM		6,450,631	5/02	Hayashi, et al.	347	86	
LEM		6,471,343	10/02	Shimizu, et al.	347	85	
LEM		6,505,923	1/03	Yamamoto, et al.	347	85	
LEM		6,511,167	1/03	Kitabatake, et al.	347	86	
LEM		6,530,654	3/03	Kitabatake, et al.	347	86	
LEM		6,543,886	4/03	Hattori, et al.	347	85	
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LEM		6,554,411	4/03	Hatasa, et al.	347	86	
LEM		6,598,963	1/03	Yamamoto, et al.	347	85	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
LEM		2001-270131	10/01	Japan			Abstract
LEM		2001-293880	10/01	Japan			Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
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			APPLICANT Nobuyuki Hatasa et al.			
			FILING DATE November 24, 2003		GROUP 2861	

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*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
UAM	6,702,427	03/2004	Shimizu, et al.	347	86	
UAM	6,709,092	03/2004	Hayashi, et al.	347	86	
UAM	6,712,458	03/2004	Hatsa, et al.	347	86	
UAM	6,742,857	06/2004	Koshikawa, et al.	347	19	
UAM	6,805,434	10/2004	Hayashi, et al.	347	85	
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UAM	2003-0043241	03/2003	Hattori, et al.	347	85	
UAM	2003-0234844	12/2003	Yamamoto, et al.	347	19	
UAM	2004-0160756	03/2004	Furuya, et al.	362	27	

FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)	

EXAMINER <u>UAM</u>	DATE CONSIDERED <u>6/4/05</u>
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